

Reconfigurable Wave Velocity Transmission Lines for Phased Arrays

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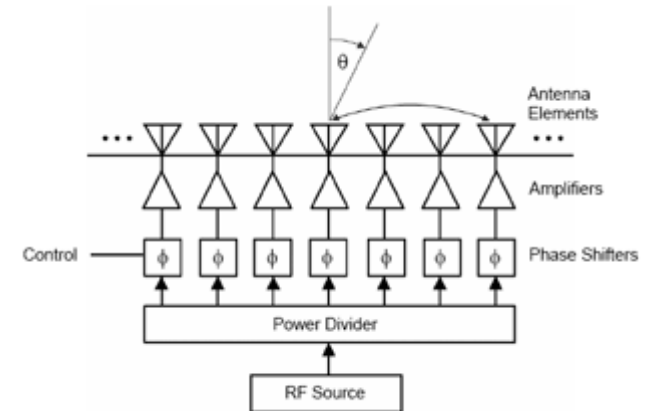


Phased Array Features:

- *Wideband*
 - Element Design allows for wideband operation
- *Beam Scanning Ability*
 - Element phase control allows for beam scanning

Phased Array Challenges:

- *Complex*
 - Backend used to achieve beam steering is very complex
- *Heavy*
 - The backend adds significant weight
- *Costly*
 - Components are very expensive



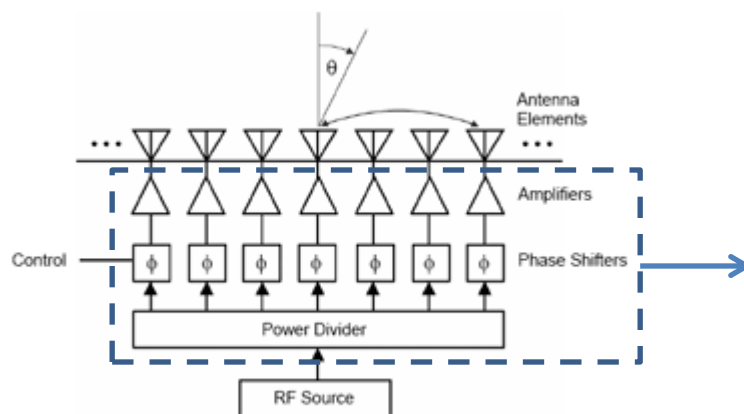
Addressed by
our approach

Design Goals:

- *Reduce Complexity*
- *Reduce Weight*
 - Large contributions for both come from the backend
- *Reduce Cost*

Methodology:

- *Replace backend with simpler feeding mechanism*



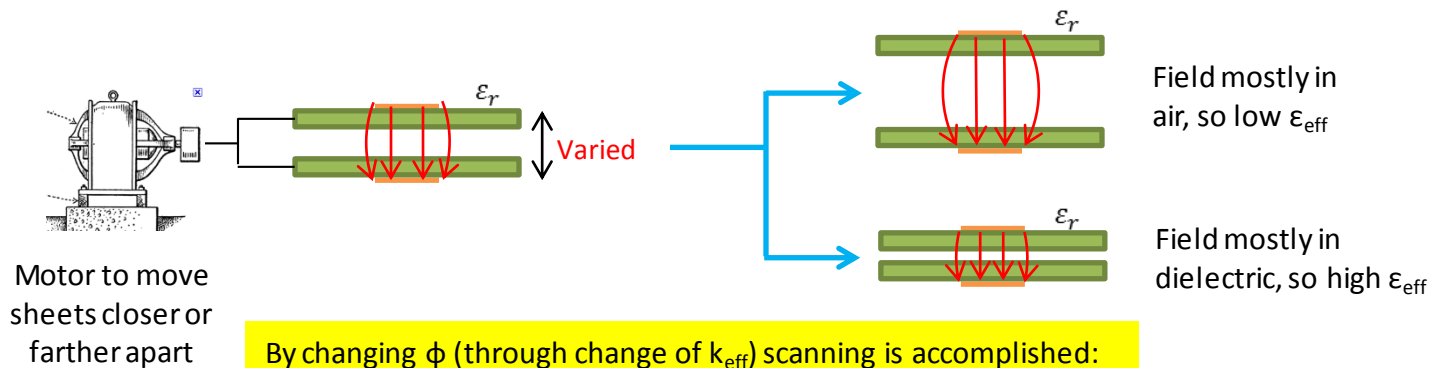
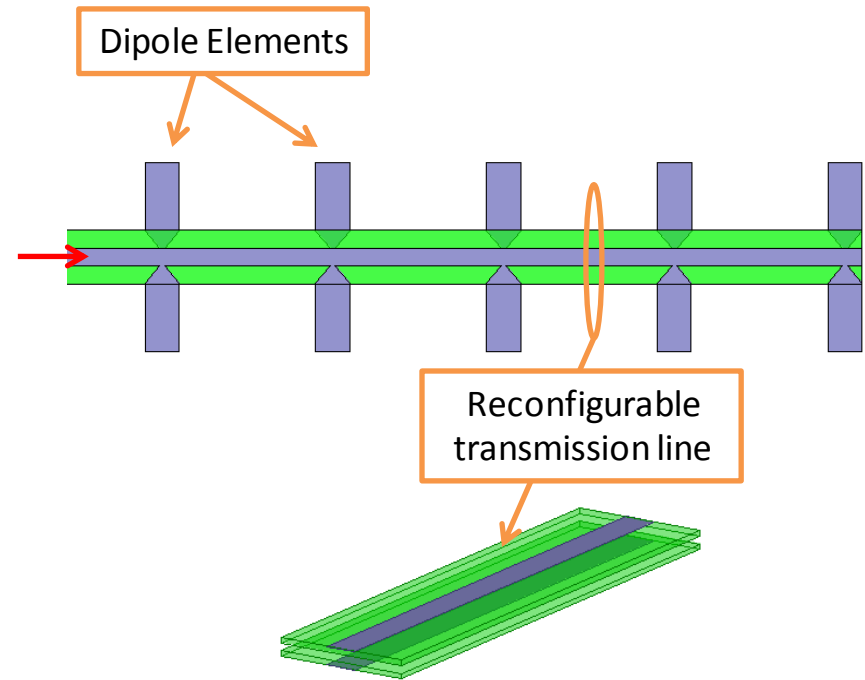
Replace with
simpler
mechanism

Replace Backend With Simpler Mechanism

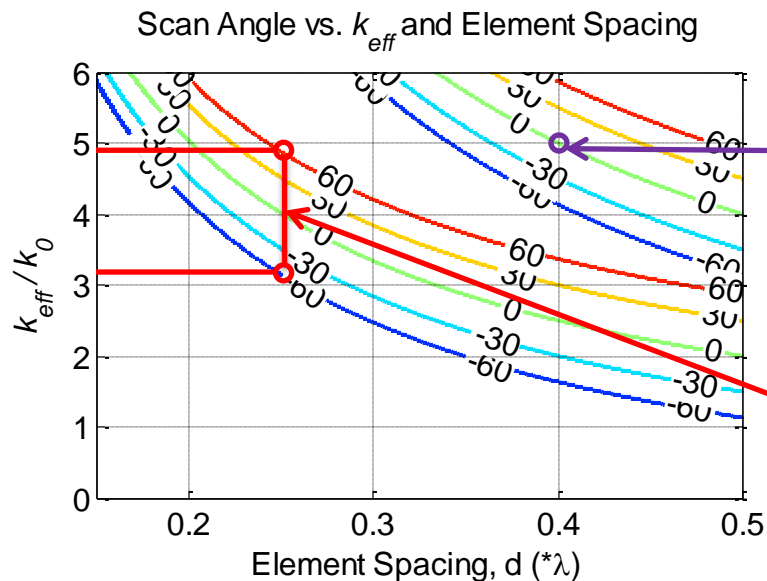
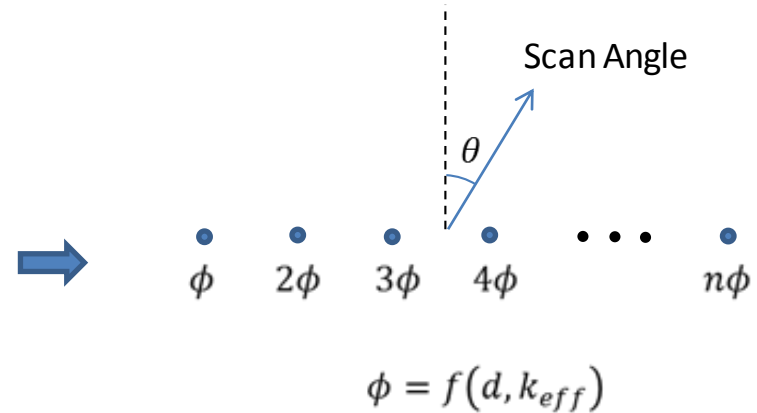
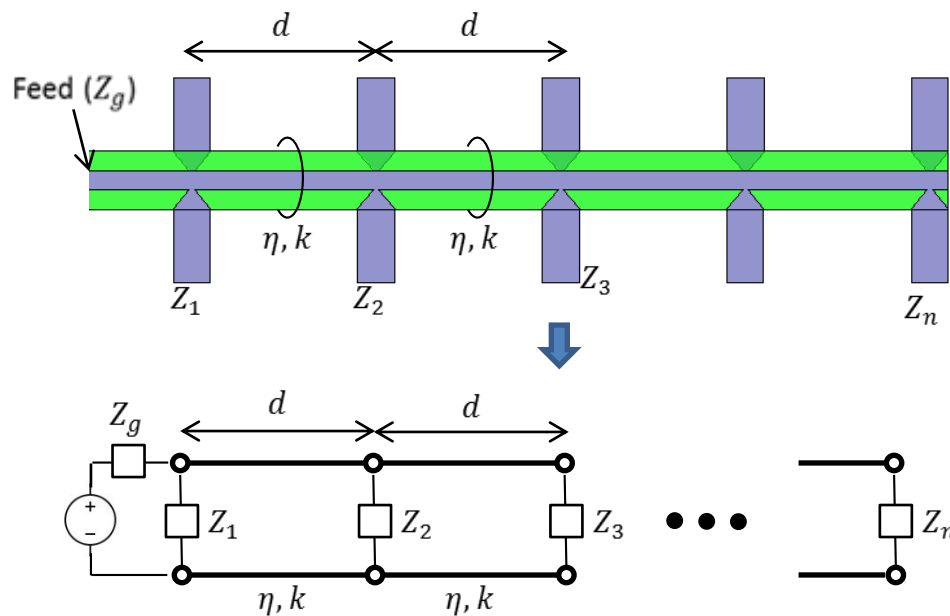
- *Get rid of all splitters, phase shifters, and amps*

Use Series Fed Array:

- *Array fed at one point (side)*
- *Magnitude at each element controlled by varied mismatch at element terminals*
- *Beam Steering will be accomplished by a controllable propagation constant between elements*
 - A motor can bring two fixed sheets closer to change the effective dielectric constant



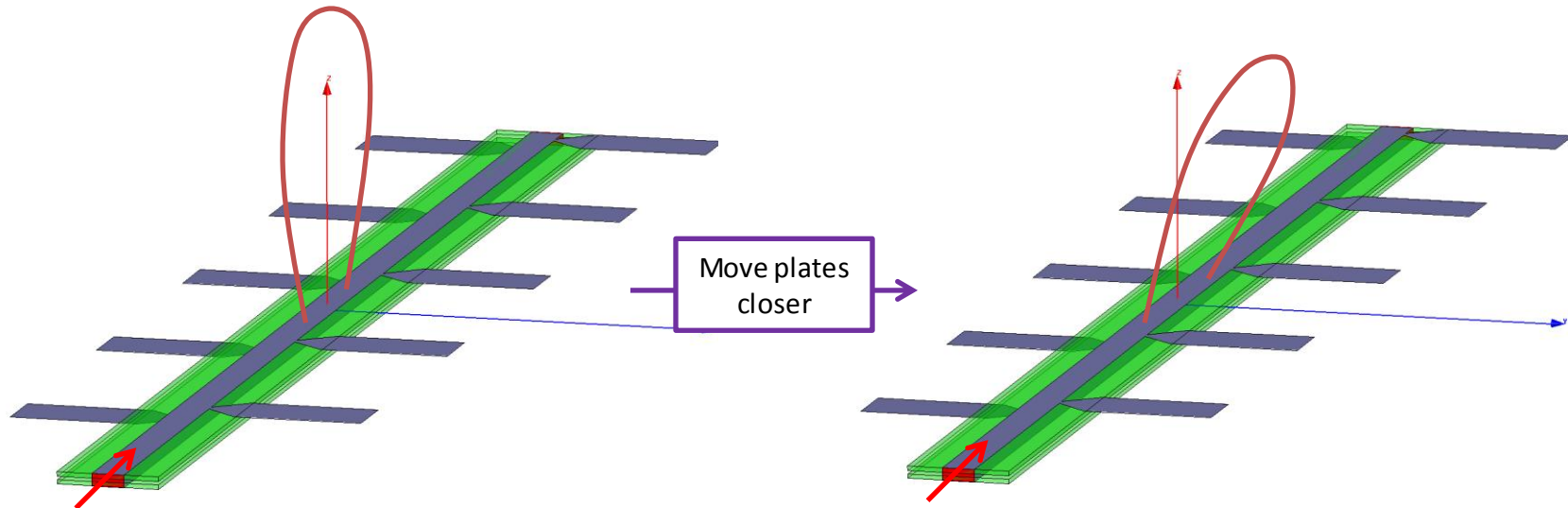
Needed Transmission Line Agility



For $d = 0.4\lambda$ and $\frac{k_{eff}}{k_0} = 5 \Rightarrow \theta = 0^\circ$

For $\theta = -60$ to 60 at $d = 0.25\lambda \Rightarrow \text{Need } 3.1 \leq \frac{k_{eff}}{k_0} \leq 4.9$

Achieving Scanning

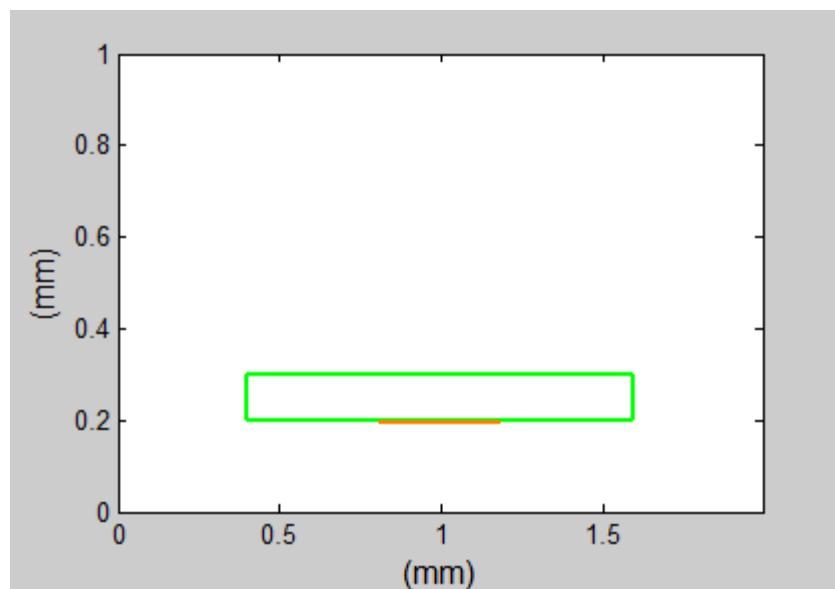


Scanning is achieved with one mechanical motion and no phase shifters

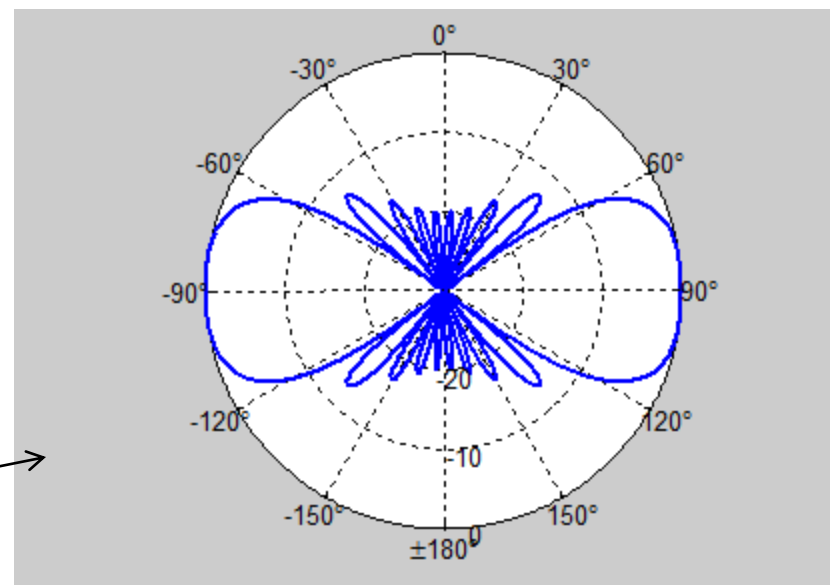
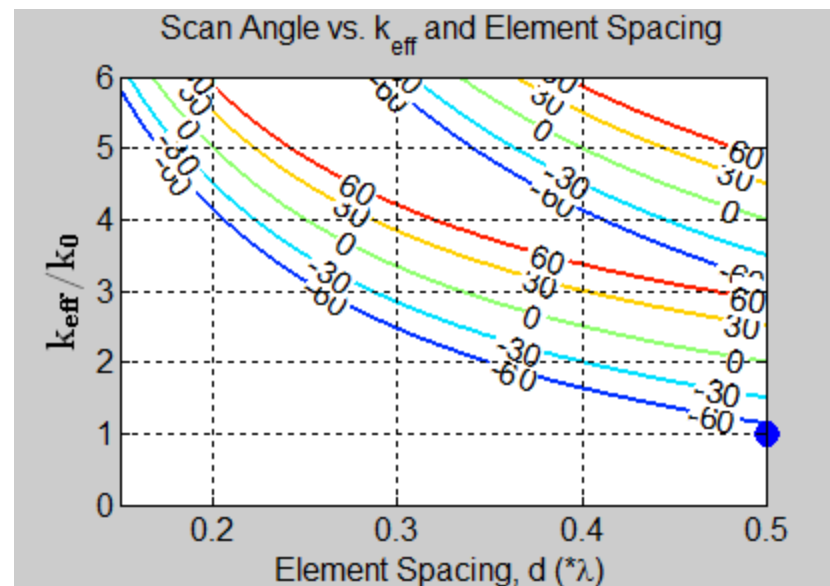
Process to Scan

As the parallel plates close (left)

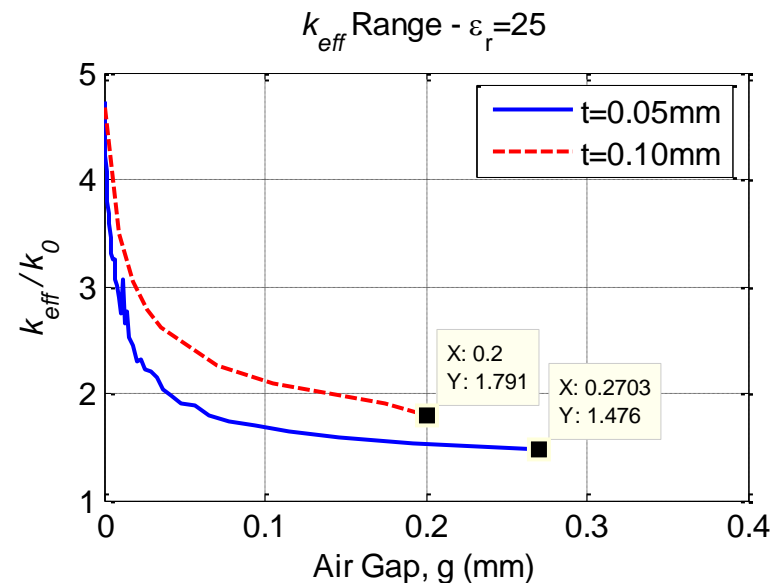
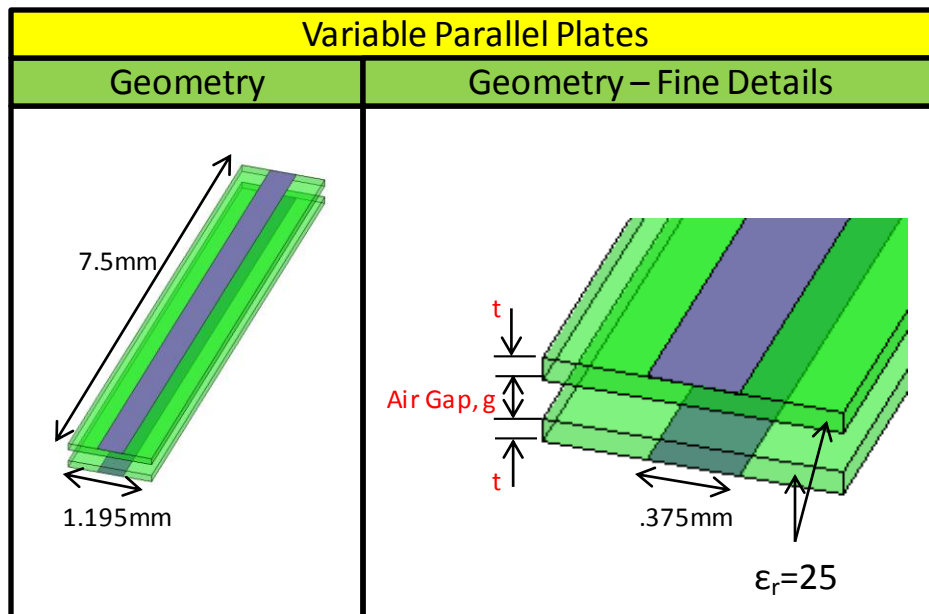
- $k_{eff} \uparrow$ (right top)
- For given $d = \lambda/2$
 - Scan angle (right top)
 - Pattern (right bottom)



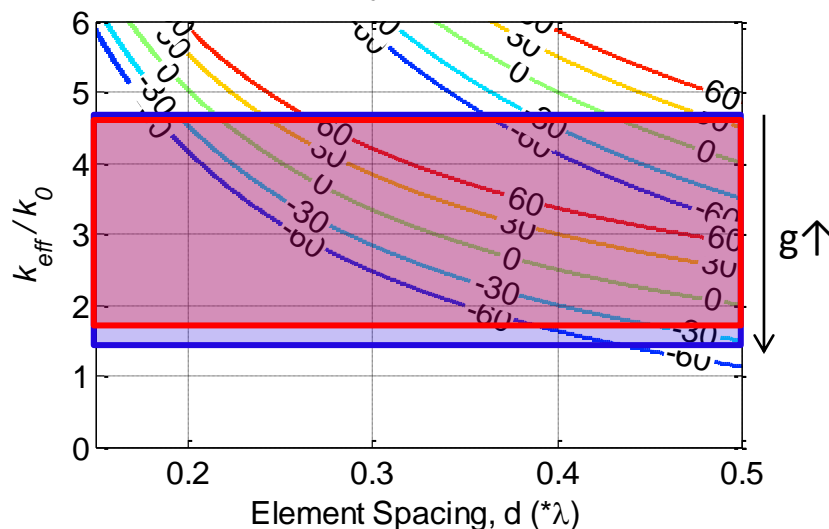
Theoretical 10
Element array with
 $\lambda/2$ element spacing



Achievable k_{eff} Range - $\epsilon_r = 25$



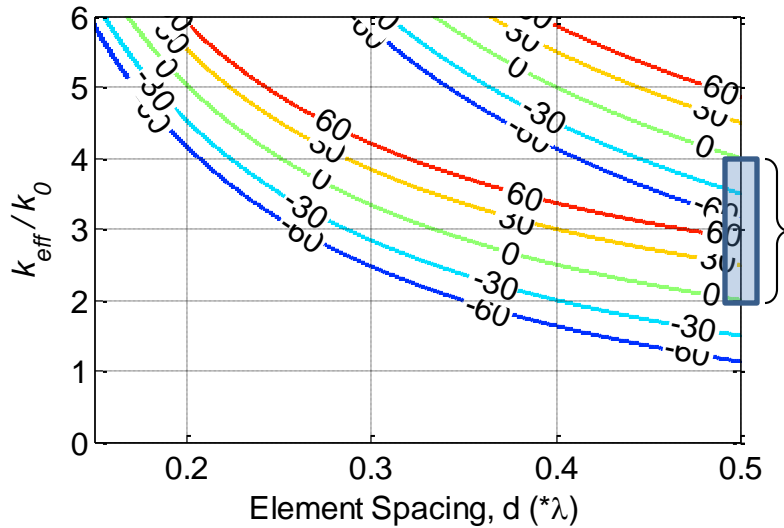
Scan Angle vs. k_{eff} and Element Spacing



- Strip Spacing $\leq 0.40\text{mm}$ ($\lambda/20$ @ 40GHz)
 - $t=0.1\text{mm}$ case \rightarrow lower max g
- $t=0.05\text{mm}$
 - Larger $\epsilon_{eff}\mu_{eff}$ range
 - More precision needed
- $t=0.10\text{mm}$
 - Smaller $\epsilon_{eff}\mu_{eff}$ range
 - Less precision needed

Transmission Line Attributes

Scan Angle vs. k_{eff} and Element Spacing



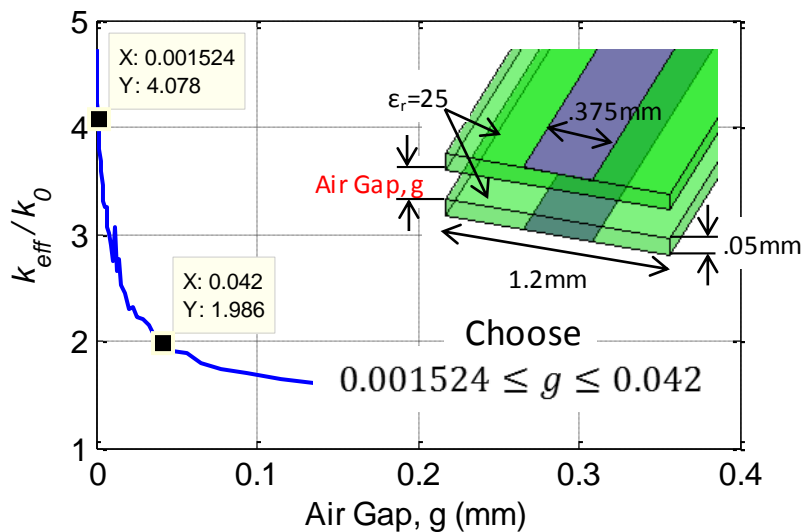
$$d = \frac{\lambda}{2}$$

$$2 \leq \frac{k_{eff}}{k_0} \leq 4$$

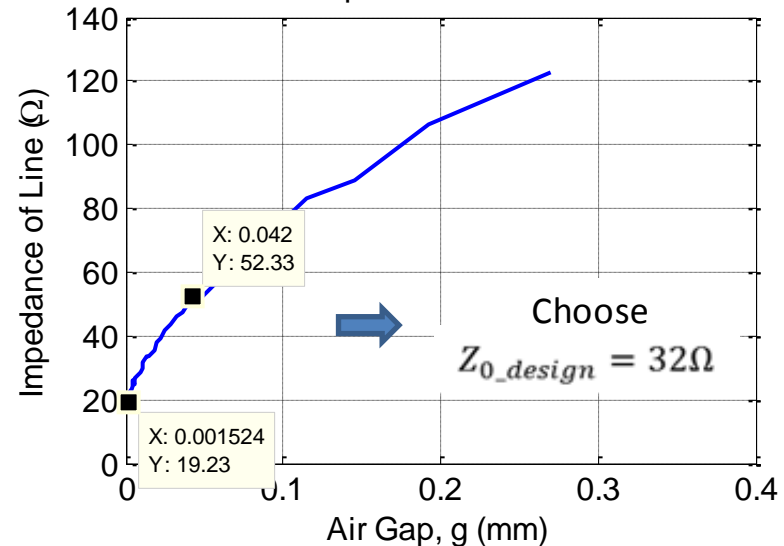


Can scan to all angles

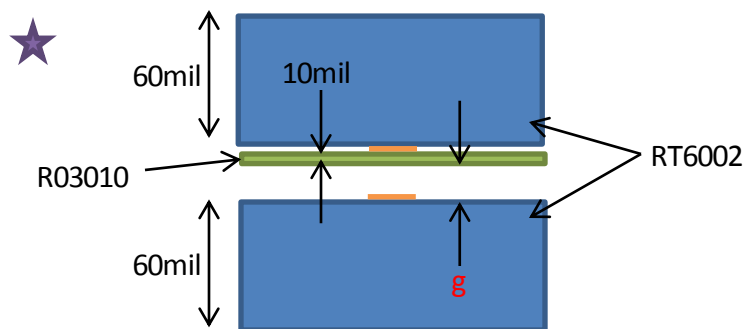
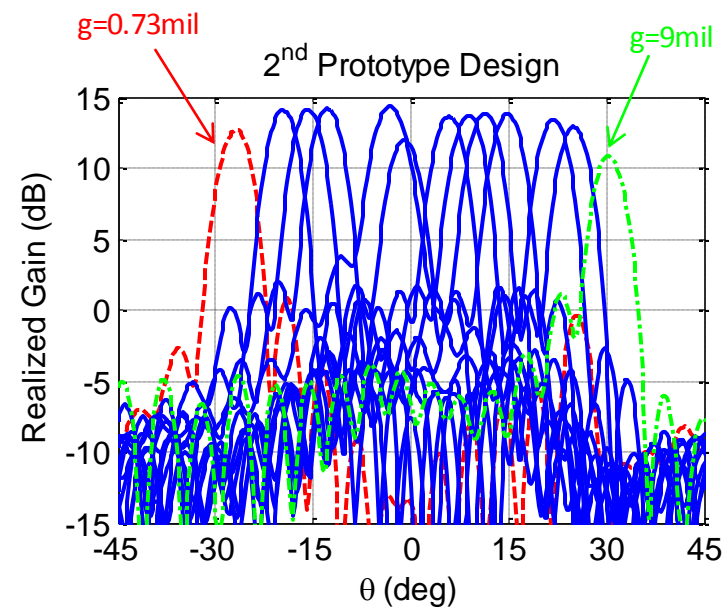
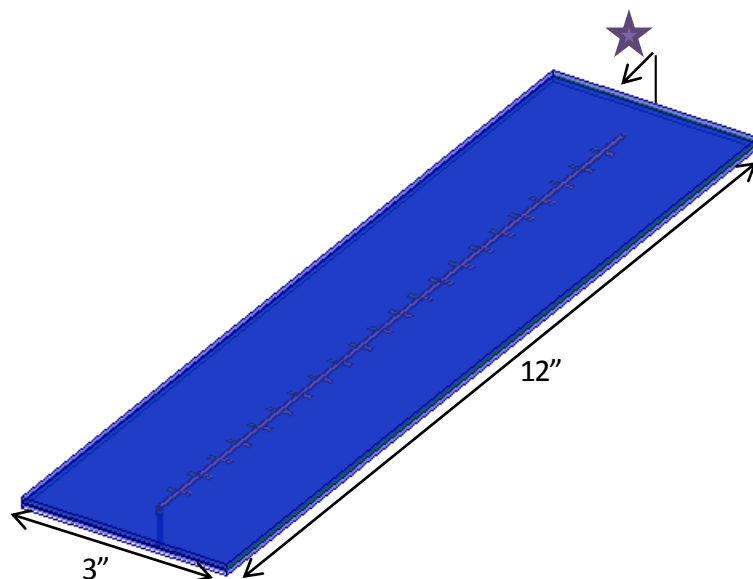
k_{eff} Range - $\epsilon_r = 25$



Impedance of Line



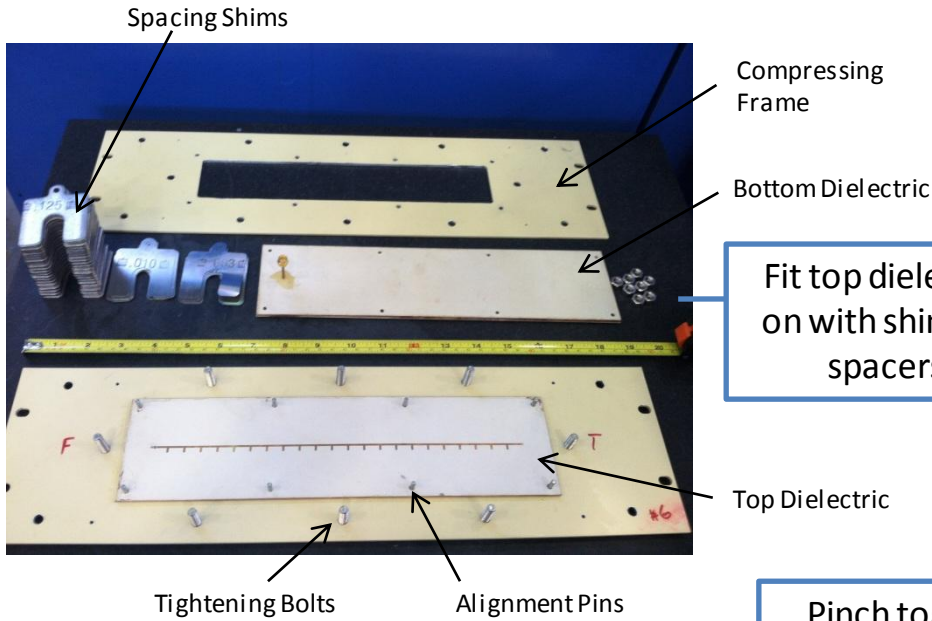
22 Element Prototype Design



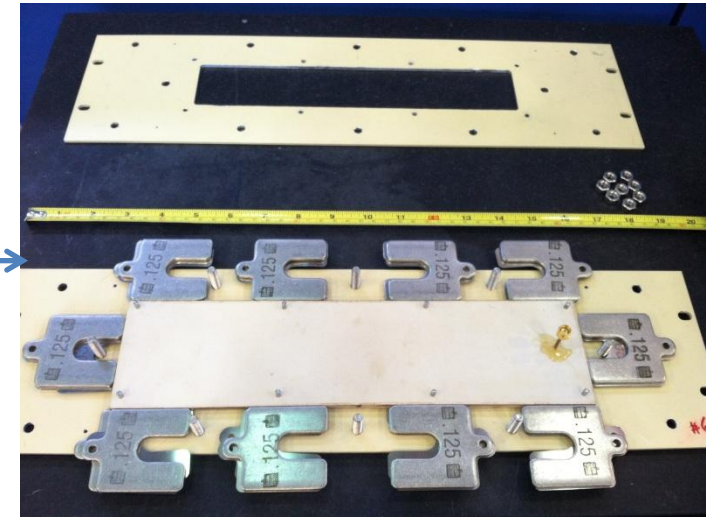
Practical Transmission Line Design

- Circuit printed on two 60mil thick RT6002 boards
 - RO3010 becomes ripply when unsupported
- RO3010 material bonded to inside of one of boards

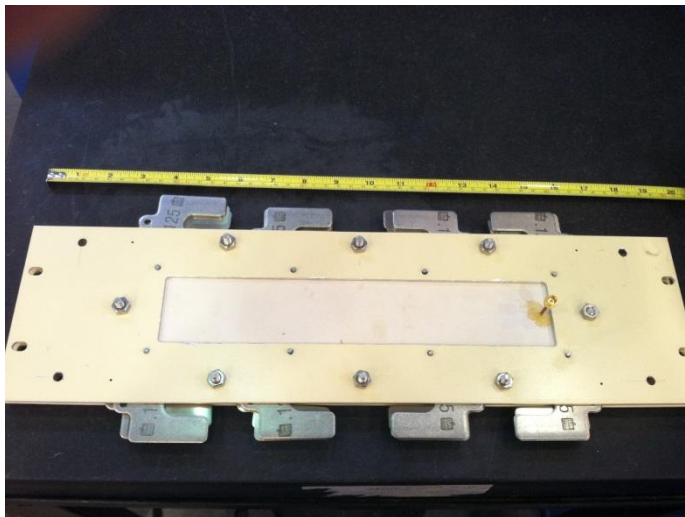
Assembly of Prototype

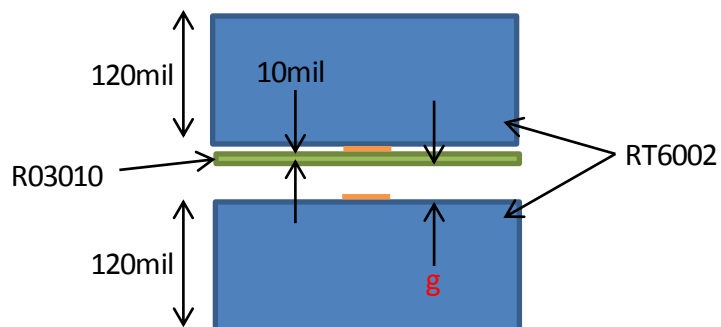


Fit top dielectric on with shims as spacers

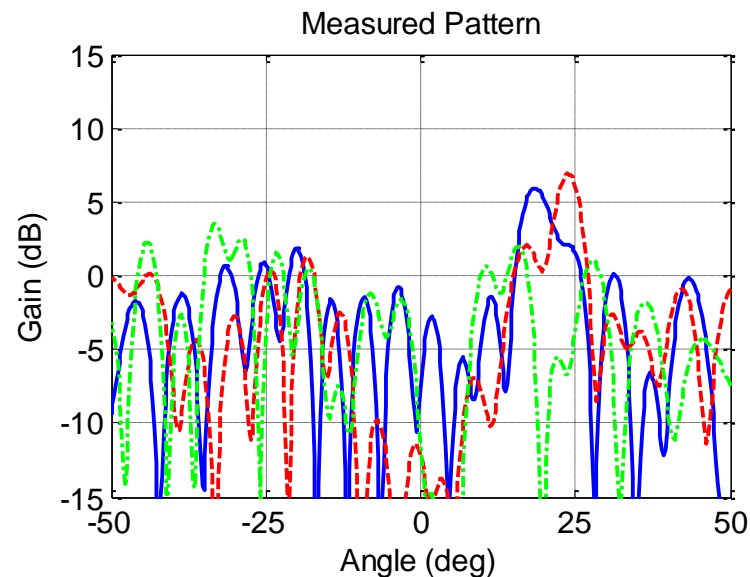
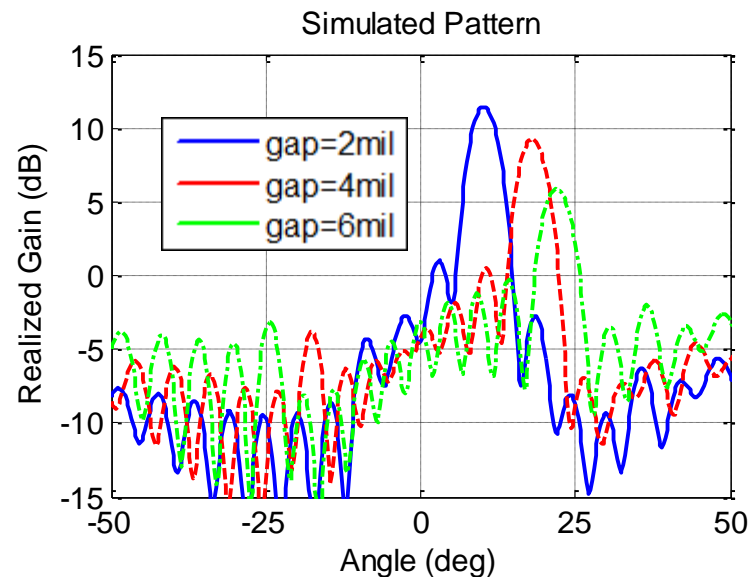


Pinch together two boards with metal frames

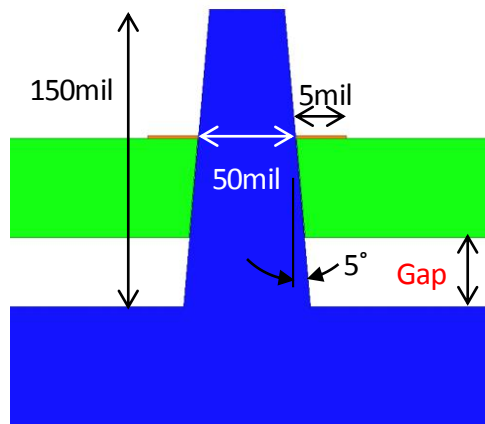
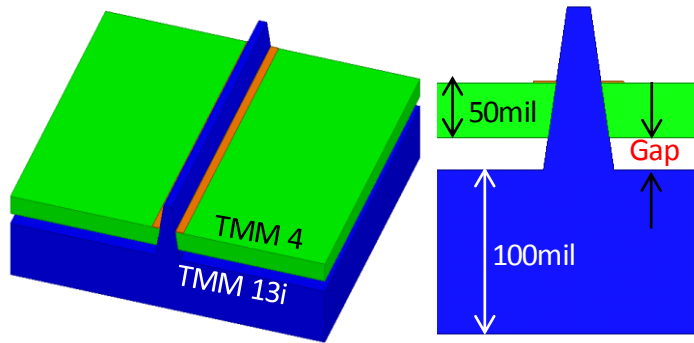




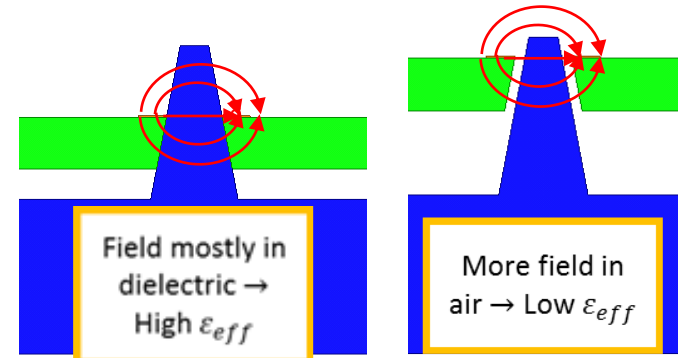
- Scanning Observed
- Achieving gap imprecise
 - Patterns shifted
 - Gain Lowered



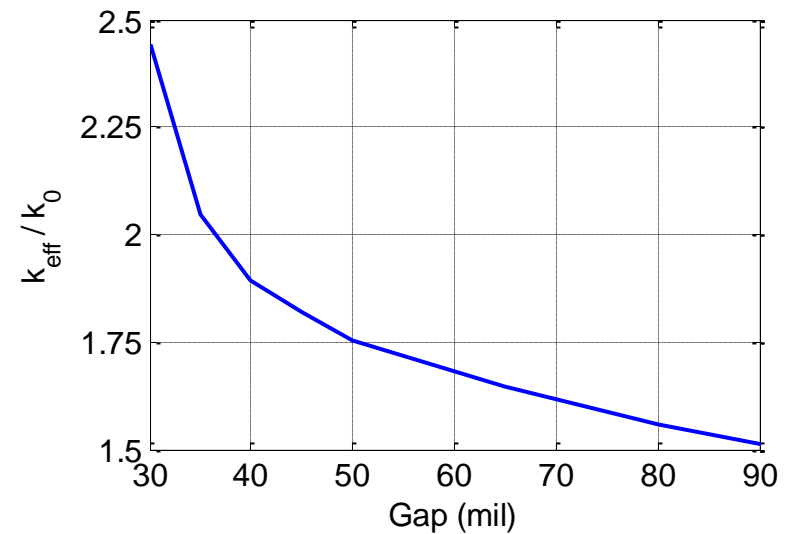
Design



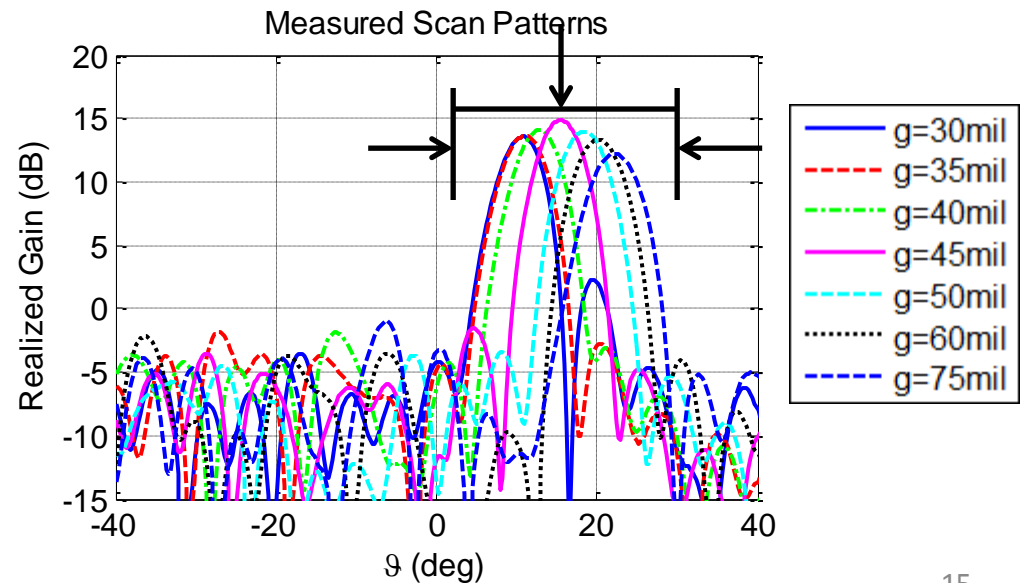
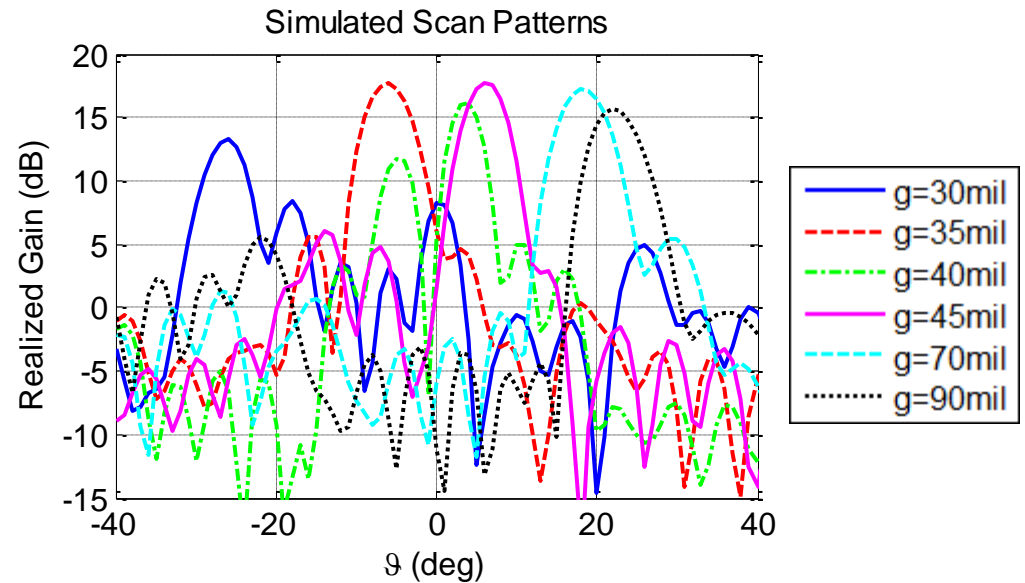
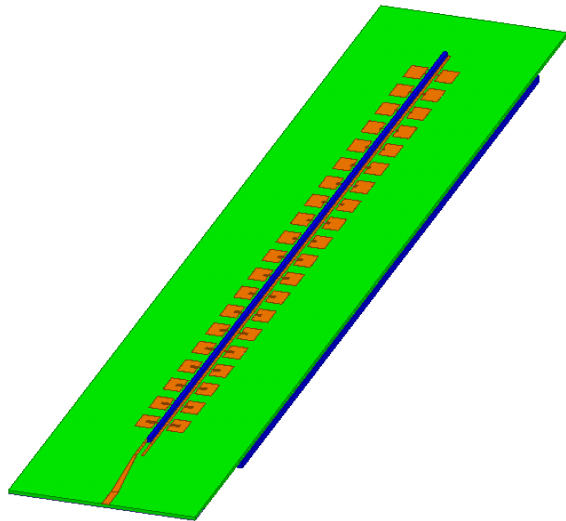
Operation



Change of k_{eff} as Gap is Increased

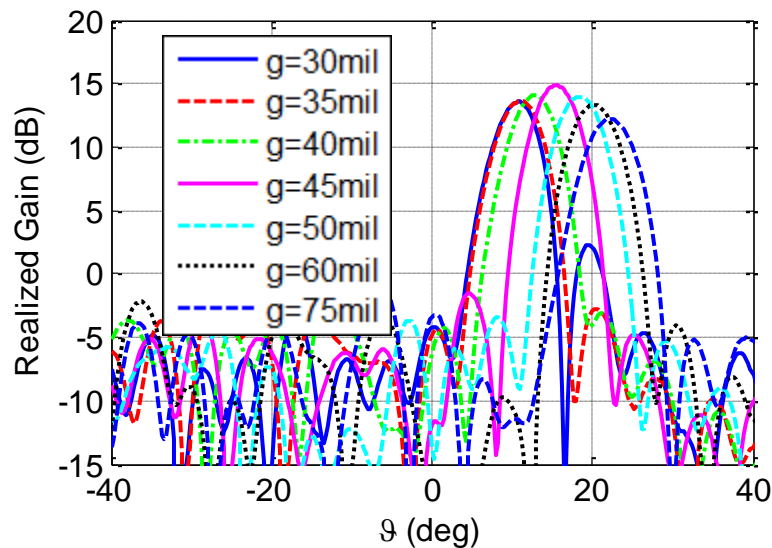


Simulated vs. Measured



Simulating Known Differences

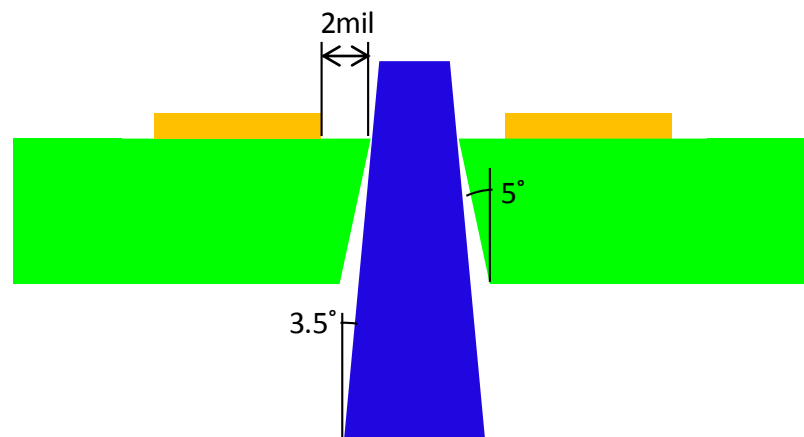
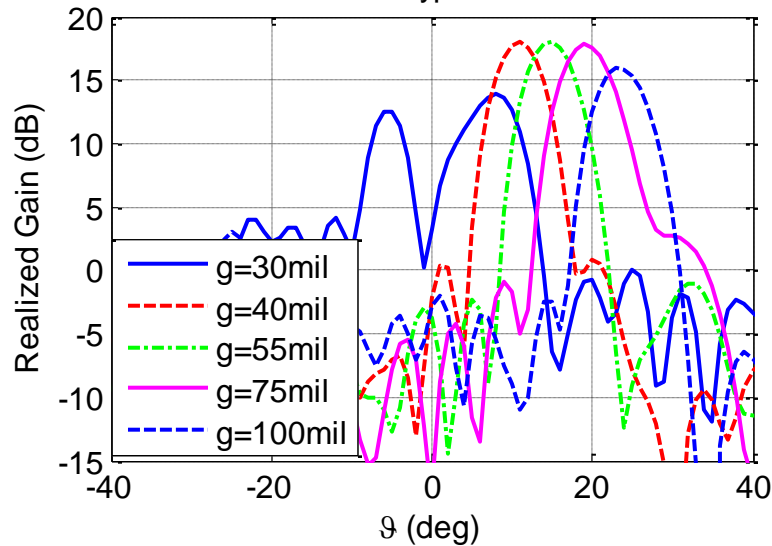
Measured Scan Patterns



Simulated with known differences

- Ridge dimensions
- Overetch

Simulated Prototype Scan Patterns



2-D Scanning

- *One feed*
- *Independent control of each scanning axis*

Ka Band

- *Smaller dimensions*

